

Search Notes

Application/Control No.

10/728,597

Examiner

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Applicant(s)/Patent under
Reexamination

ENMEI, TOSHIHARU

Art Unit

2625

SEARCHED

Class	Subclass	Date	Examiner
update		7/8/2008	AV

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East	7/8/2008	AV